

Application No.	Applicant(s)	
10/657,639	LAI ET AL.	
Examiner	Art Unit	
Christopher M. Keehan	1712	

	SEARCHED		
Class	Subclass	Date	Examiner
556	425	2/2/2005	СМК
	443		
	450		
	453		
528	28		
106	31.51		
	31.52		
525	100		
	106		
351	156		
	160R		
	162		
264	1.1		
623	6.11		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
same as	above	2/2/2005	СМК
		,	

SEARCH (INCLUDING SEAR		()
	DATE	EXMR
EAST	2/2/2005	СМК
STN search		
Inventor name search		

Search N	lotes (continued	I)

Application No.	Applicant(s)
10/657,639	LAI ET AL.
Examiner	Art Unit
Christopher M. Keehan	1712

	SEARCHED		
Class	Subclass	Date	Examiner
6.11	6.12		
	6.56		
	6.6		
		,	_

INTERFERENCE SEARCHED			
Class	Subclass	Date .	Examiner
same as	above	2/2/2005	СМК
	,		
	I		
	i		

(INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		-
-		
	•	 -
	·	
		